

## MOSFET

### 600V CoolMOS™ CM8 Power Transistor

Built on Infineon's world-class super-junction MOSFET platform with an integrated fast body diode, making it suitable for a wide range of applications. It enables highest power density at lowest possible system cost with superior reliability. It is enhancing Infineon's WBG offering and the successor of the 600 V CoolMOS™ 7 MOSFET family.

### Features

- Best-In-Class SJ Mosfet Performance
- Address broad hard and soft switching applications with outstanding commutation ruggedness
- Integrated fast body diode and ESD protection
- .XT interconnection technology for best-in-class thermal performance

### Benefits

- Provides the best price performance ratio with Best-In-Class SJ Mosfet Performance
- Ease of use and shorter design in cycle
- Enable multiple topologies
- 14-42% lower  $R_{th}$  for improved thermal performance

### Potential applications

- Datacenter, AI server, Telecom Power Supply
- Micro and Residential Hybrid Inverter
- Portable and Residential Energy Storage, UPS
- EV Charging, Light electric vehicles, Electric Forklift
- High Voltage Solid State Power Distribution
- Home & Professional Tools
- Charger, Adapters, TV and Console SMPS

### Product validation

Fully qualified according to JEDEC for Industrial Applications

*Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.*

**Table 1 Key performance parameters**

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	99	mΩ
$Q_{g,typ}$	31	nC
$I_{D,pulse}$	87	A
$E_{oss} @ 400V$	4.2	μJ
Body diode $di_F/dt$	1300	A/μs

Type / Ordering code	Package	Marking	Related links
IPT60R099CM8	PG-HSOF-8	60R099C8	see Appendix A

TOLL

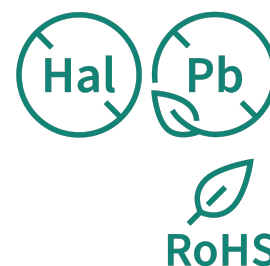
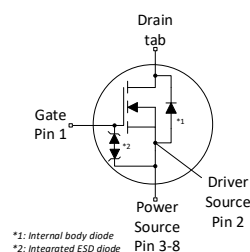
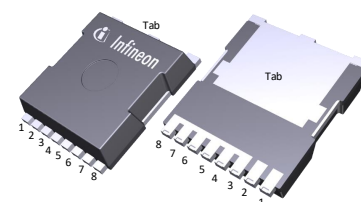




Table of contents

Description ..... 1

Maximum ratings ..... 3

Thermal characteristics ..... 4

Electrical characteristics ..... 5

Electrical characteristics diagrams ..... 7

Test circuits ..... 11

Package outlines ..... 12

Appendix A ..... 15

Revision history ..... 16

Trademarks ..... 16

Disclaimer ..... 16

# 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	30	A	$T_C = 25^\circ\text{C}$
Continuous drain current	$I_D$	-	-	18	A	$T_C = 100^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,pulse}$	-	-	87	A	$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$	-	-	51	mJ	$I_D = 2.7\text{A}$ ; $V_{DD} = 50\text{V}$ ; see table 10
Avalanche energy, repetitive	$E_{AR}$	-	-	0.26	mJ	$I_D = 2.7\text{A}$ ; $V_{DD} = 50\text{V}$ ; see table 10
Avalanche current, single pulse	$I_{AS}$	-	-	2.7	A	-
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	$V_{DS} = 0 \dots 400\text{V}$
Gate source voltage (static)	$V_{GS}$	-20	-	20	V	static;
Gate source voltage (dynamic)	$V_{GS}$	-30	-	30	V	AC ( $f > 1\text{ Hz}$ )
Power dissipation	$P_{tot}$	-	-	186	W	$T_C = 25^\circ\text{C}$
Storage temperature	$T_{stg}$	-55	-	150	$^\circ\text{C}$	-
Operating junction temperature	$T_j$	-55	-	150	$^\circ\text{C}$	-
Extended operating junction temperature	$T_j$	150	-	175	$^\circ\text{C}$	$\leq 50\text{ h}$ in the application lifetime
Mounting torque	-	-	-	-	Ncm	-
Continuous diode forward current	$I_S$	-	-	30	A	$T_C = 25^\circ\text{C}$
Diode pulse current <sup>2)</sup>	$I_{S,pulse}$	-	-	87	A	$T_C = 25^\circ\text{C}$
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	70	V/ns	$V_{DS} = 0 \dots 400\text{V}$ , $I_{SD} \leq 30\text{A}$ , $T_j = 25^\circ\text{C}$ see table 8
Maximum diode commutation speed	di <sub>F</sub> /dt	-	-	1300	A/ $\mu\text{s}$	$V_{DS} = 0 \dots 400\text{V}$ , $I_{SD} \leq 30\text{A}$ , $T_j = 25^\circ\text{C}$ see table 8
Insulation withstand voltage	$V_{ISO}$	-	-	n.a.	V	$V_{rms}$ , $T_C = 25^\circ\text{C}$ , $t = 1\text{min}$

<sup>1)</sup> Limited by  $T_{j,max}$ .

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$ .

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$ .

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.67	K/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62	K/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	$R_{thJA}$	-	-	-	K/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm <sup>2</sup> (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Soldering temperature, wave- & reflow soldering allowed	$T_{sold}$	-	-	260	°C	reflow MSL1

### 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	600	-	-	V	$V_{GS}=0\text{V}$ , $I_D=1\text{mA}$
Gate threshold voltage	$V_{(GS)th}$	3.7	4.2	4.7	V	$V_{DS}=V_{GS}$ , $I_D=0.26\text{mA}$
Zero gate voltage drain current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$ , $T_j=25^\circ\text{C}$ $V_{DS}=600\text{V}$ , $V_{GS}=0\text{V}$ , $T_j=150^\circ\text{C}$
Gate-source leakage current	$I_{GSS}$	-	-	2	$\mu\text{A}$	$V_{GS}=20\text{V}$ , $V_{DS}=0\text{V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	0.083	0.099	$\Omega$	$V_{GS}=10\text{V}$ , $I_D=10.1\text{A}$ , $T_j=25^\circ\text{C}$ $V_{GS}=10\text{V}$ , $I_D=10.1\text{A}$ , $T_j=150^\circ\text{C}$
Gate resistance	$R_G$	-	8.9	-	$\Omega$	$f=1\text{MHz}$

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$	-	1330	-	pF	$V_{GS}=0\text{V}$ , $V_{DS}=400\text{V}$ , $f=250\text{kHz}$
Output capacitance	$C_{oss}$	-	18	-	pF	$V_{GS}=0\text{V}$ , $V_{DS}=400\text{V}$ , $f=250\text{kHz}$
Effective output capacitance, energy related <sup>4)</sup>	$C_{o(er)}$	-	53	-	pF	$V_{GS}=0\text{V}$ , $V_{DS}=0\dots400\text{V}$
Effective output capacitance, time related <sup>5)</sup>	$C_{o(tr)}$	-	533	-	pF	$I_D=\text{constant}$ , $V_{GS}=0\text{V}$ , $V_{DS}=0\dots400\text{V}$
Turn-on delay time	$t_{d(on)}$	-	16.2	-	ns	$V_{DD}=400\text{V}$ , $V_{GS}=13\text{V}$ , $I_D=5.1\text{A}$ , $R_G=5.3\Omega$ ; see table 9
Rise time	$t_r$	-	6	-	ns	$V_{DD}=400\text{V}$ , $V_{GS}=13\text{V}$ , $I_D=5.1\text{A}$ , $R_G=5.3\Omega$ ; see table 9
Turn-off delay time	$t_{d(off)}$	-	90.1	-	ns	$V_{DD}=400\text{V}$ , $V_{GS}=13\text{V}$ , $I_D=5.1\text{A}$ , $R_G=5.3\Omega$ ; see table 9
Fall time	$t_f$	-	9.5	-	ns	$V_{DD}=400\text{V}$ , $V_{GS}=13\text{V}$ , $I_D=5.1\text{A}$ , $R_G=5.3\Omega$ ; see table 9

<sup>4)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

<sup>5)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

**Table 6 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	8	-	nC	$V_{DD}=400\text{V}$ , $I_D=5.1\text{A}$ , $V_{GS}=0$ to 10V
Gate to drain charge	$Q_{gd}$	-	11	-	nC	$V_{DD}=400\text{V}$ , $I_D=5.1\text{A}$ , $V_{GS}=0$ to 10V

**Table 6 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate charge total	$Q_g$	-	31	-	nC	$V_{DD}=400V$ , $I_D=5.1A$ , $V_{GS}=0$ to $10V$
Gate plateau voltage	$V_{plateau}$	-	6.0	-	V	$V_{DD}=400V$ , $I_D=5.1A$ , $V_{GS}=0$ to $10V$

**Table 7 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	-	0.9	-	V	$V_{GS}=0V$ , $I_F=5.1A$ , $T_J=25^\circ C$
Reverse recovery time	$t_{rr}$	-	77.3	96.6	ns	$V_R=400V$ , $I_F=5.1A$ , $di_F/dt=100A/\mu s$ ; see table 8
Reverse recovery charge	$Q_{rr}$	-	0.30	0.45	$\mu C$	$V_R=400V$ , $I_F=5.1A$ , $di_F/dt=100A/\mu s$ ; see table 8
Peak reverse recovery current	$I_{rrm}$	-	7.8	-	A	$V_R=400V$ , $I_F=5.1A$ , $di_F/dt=100A/\mu s$ ; see table 8

4 Electrical characteristics diagrams

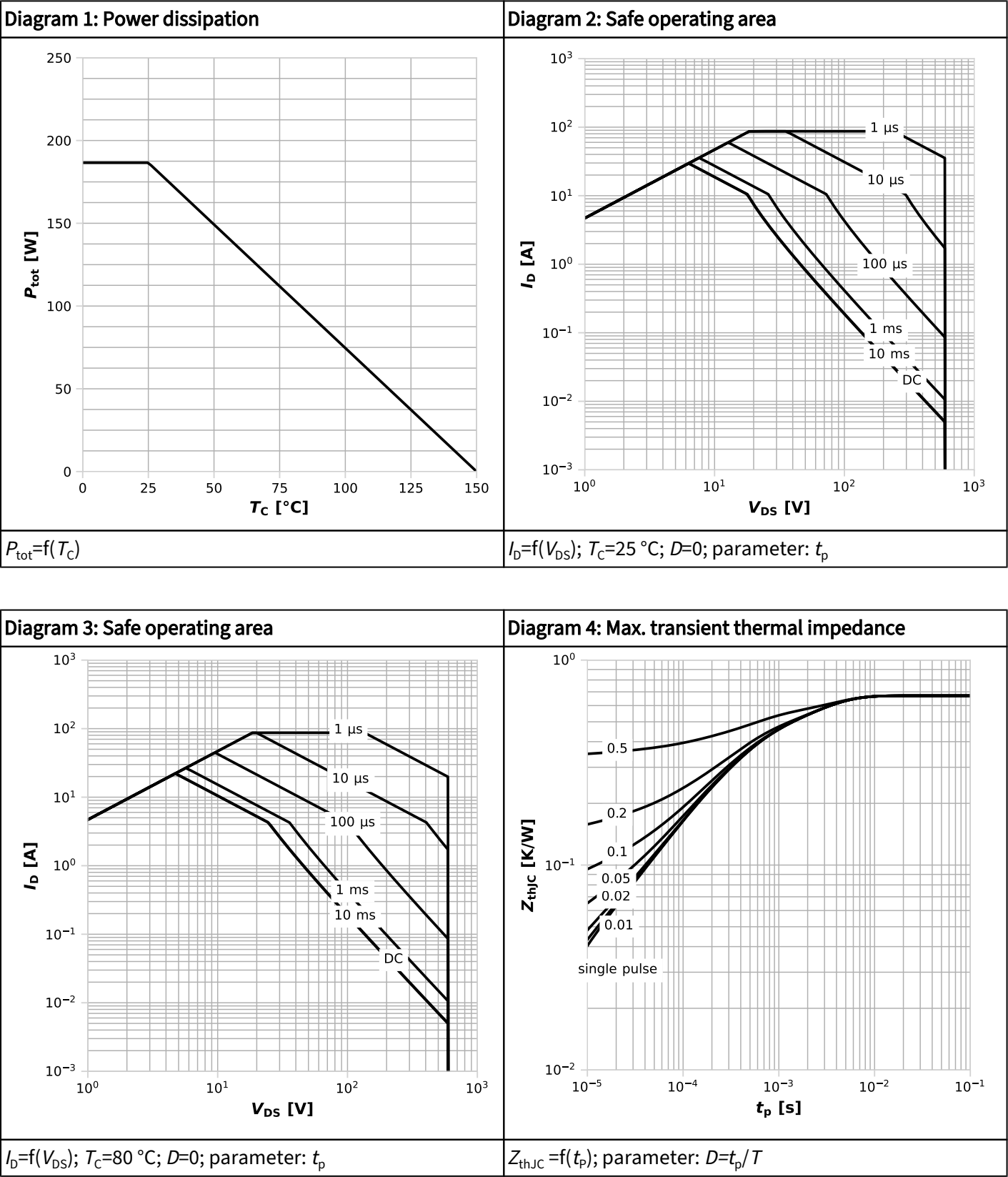
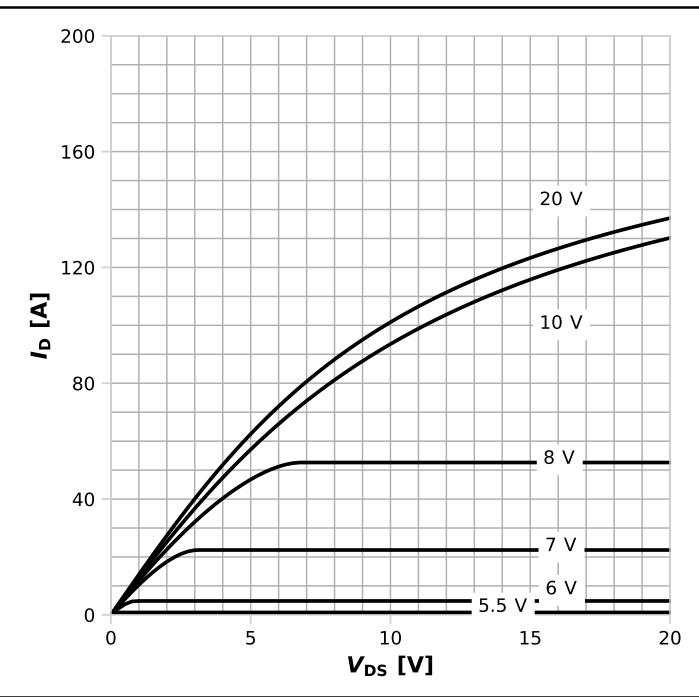
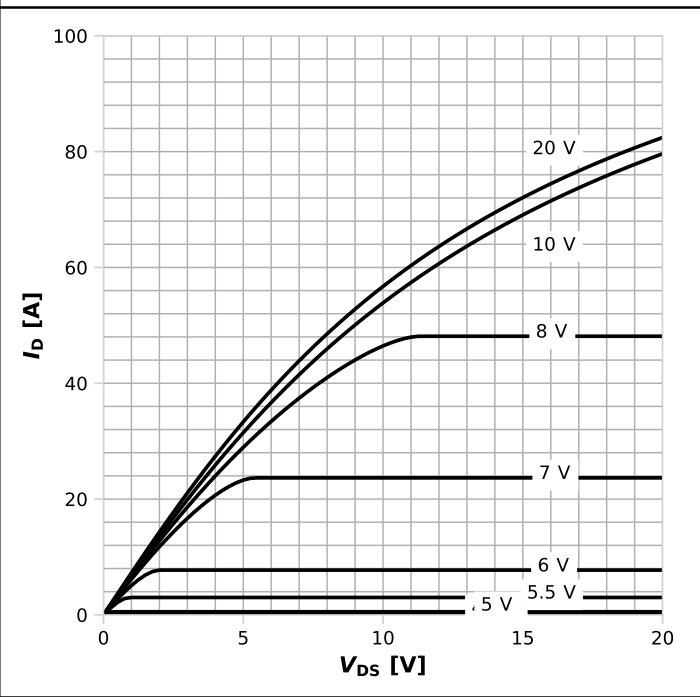


Diagram 5: Typ. output characteristics



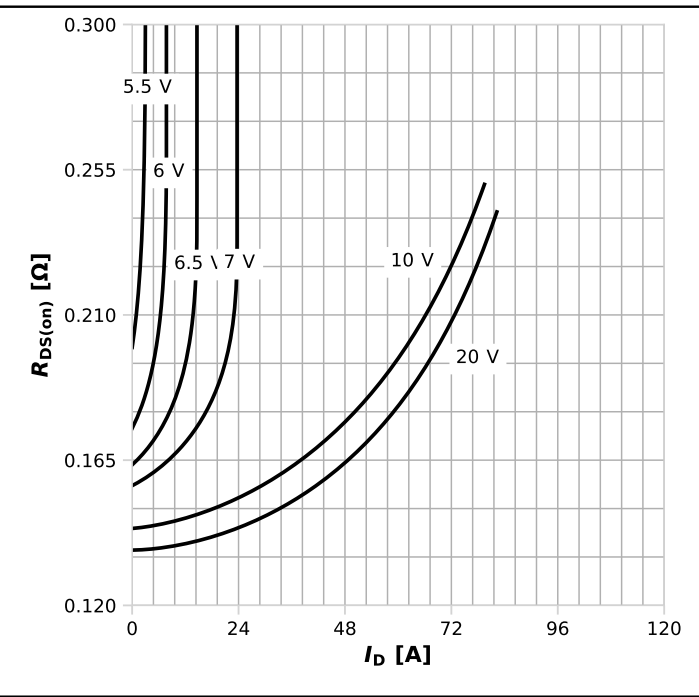
$I_D = f(V_{DS})$ ;  $T_j = 25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



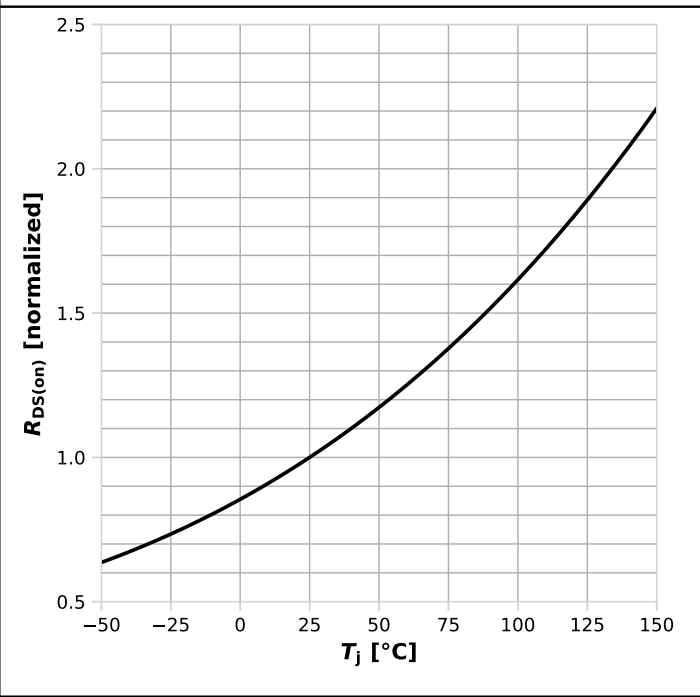
$I_D = f(V_{DS})$ ;  $T_j = 125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_D)$ ;  $T_j = 125\text{ °C}$ ; parameter:  $V_{GS}$

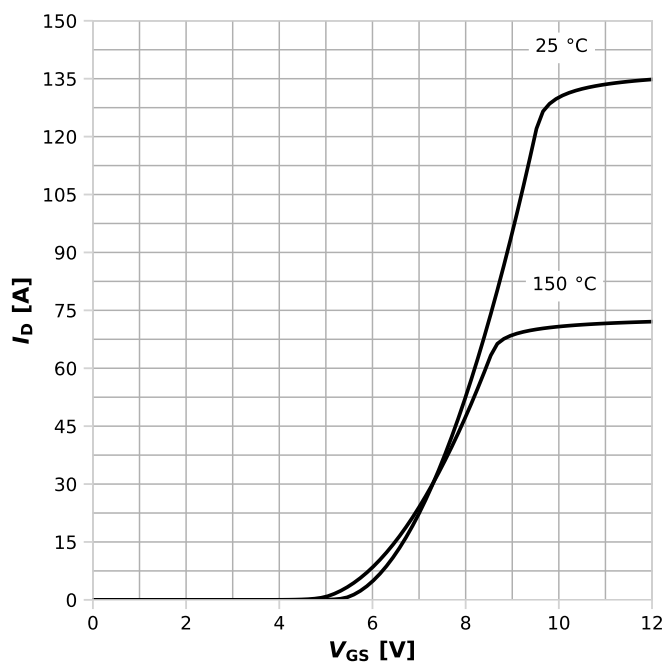
Diagram 8: Drain-source on-state resistance



$R_{DS(on)} = f(T_j)$ ;  $I_D = 10.1\text{ A}$ ;  $V_{GS} = 10\text{ V}$

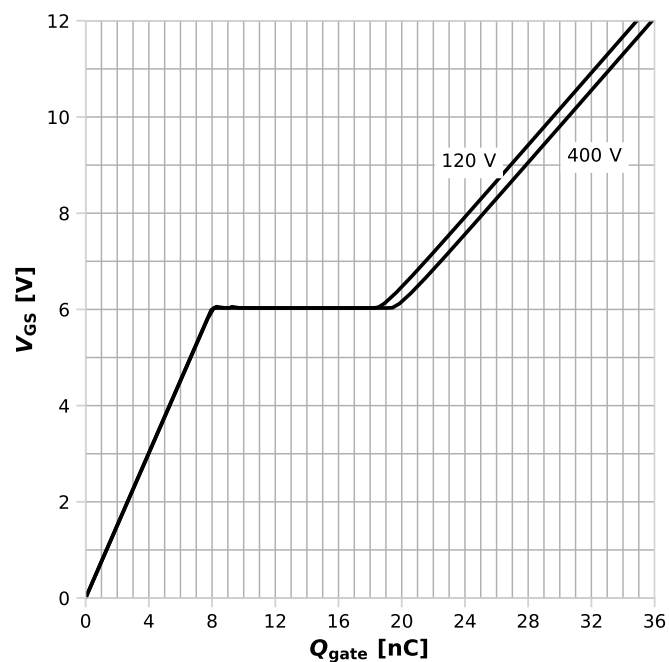


**Diagram 9: Typ. transfer characteristics**



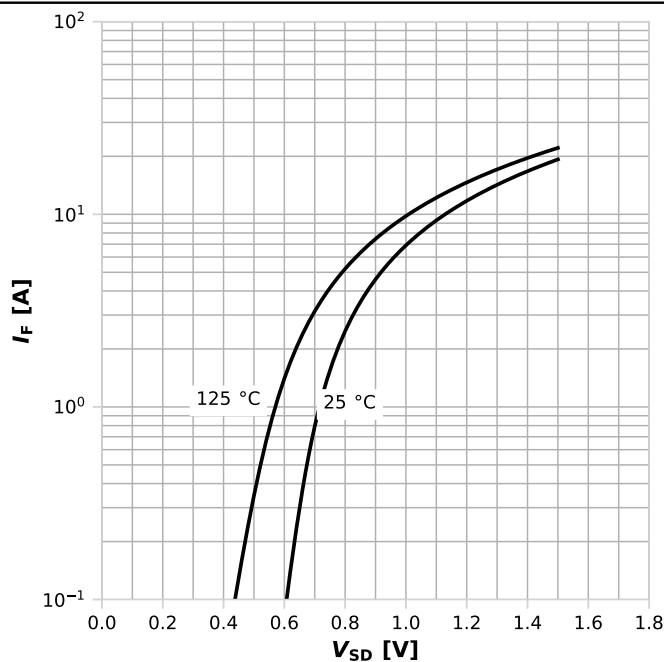
$I_D = f(V_{GS})$ ;  $V_{DS} = 20V$ ; parameter:  $T_j$

**Diagram 10: Typ. gate charge**



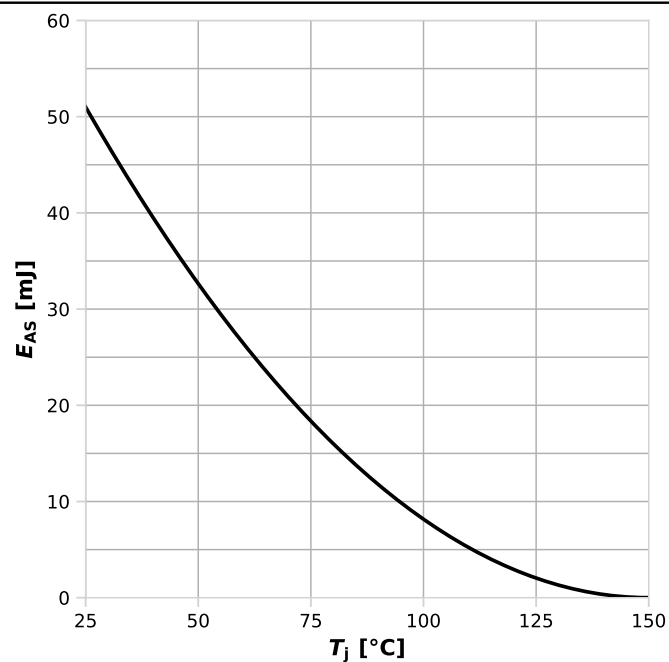
$V_{GS} = f(Q_{gate})$ ;  $I_D = 5.1$  A pulsed; parameter:  $V_{DD}$

**Diagram 11: Forward characteristics of reverse diode**



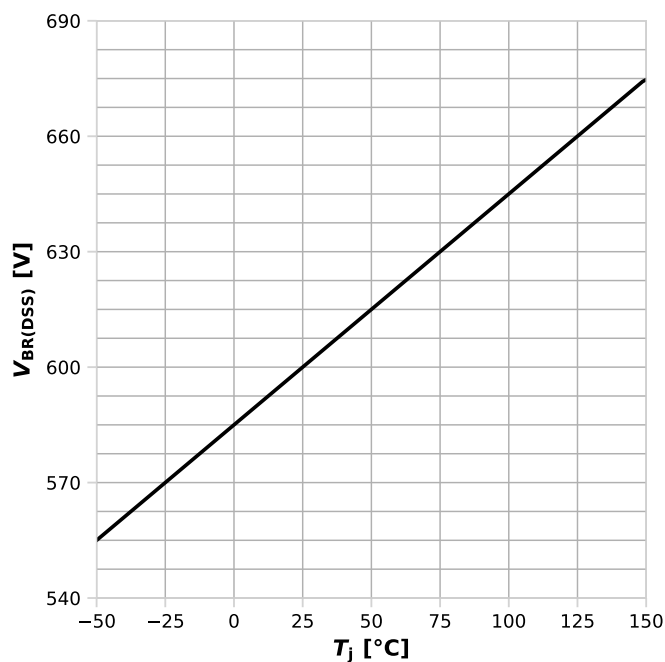
$I_F = f(V_{SD})$ ; parameter:  $T_j$

**Diagram 12: Avalanche energy**



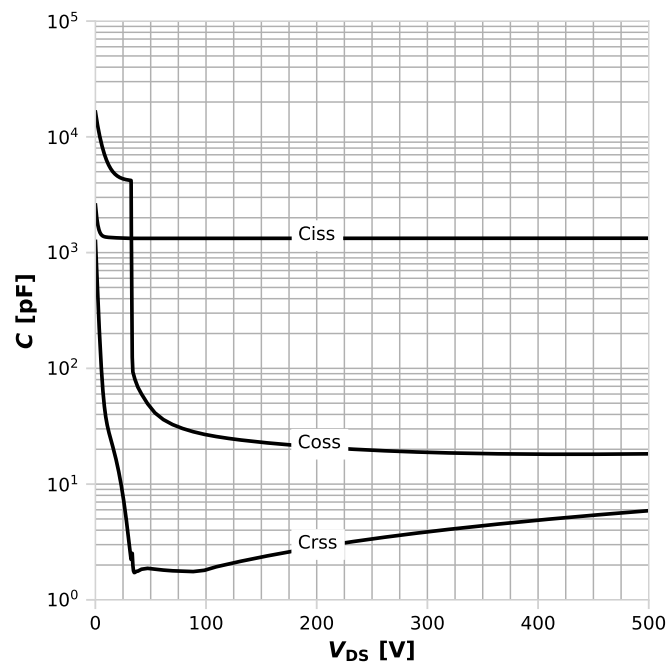
$E_{AS} = f(T_j)$ ;  $I_D = 2.7$  A;  $V_{DD} = 50$  V

**Diagram 13: Drain-source breakdown voltage**



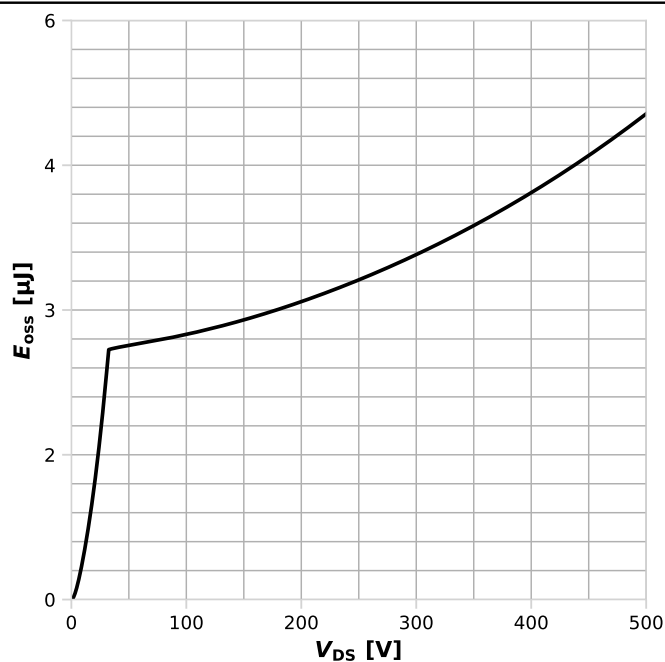
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

**Diagram 14: Typ. capacitances**



$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 250 \text{ kHz}$$

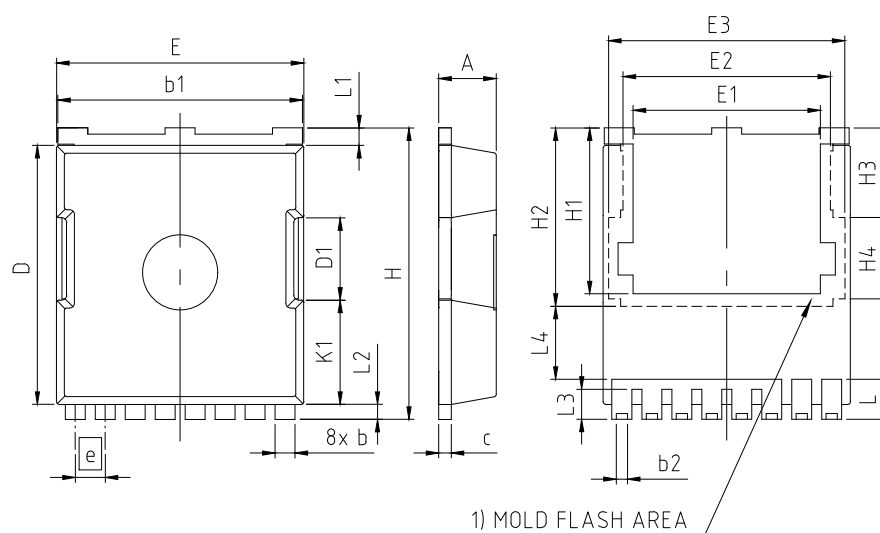
**Diagram 15: Typ. Coss stored energy**



$$E_{oss} = f(V_{DS})$$



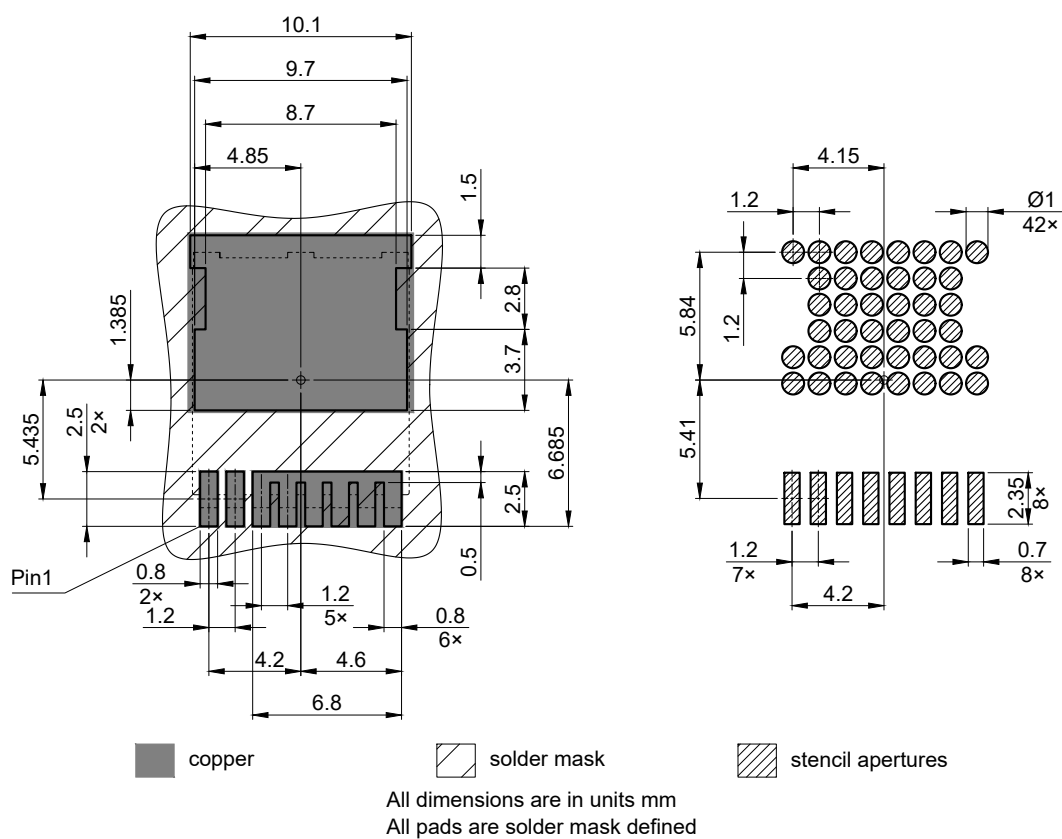
## 6 Package outlines

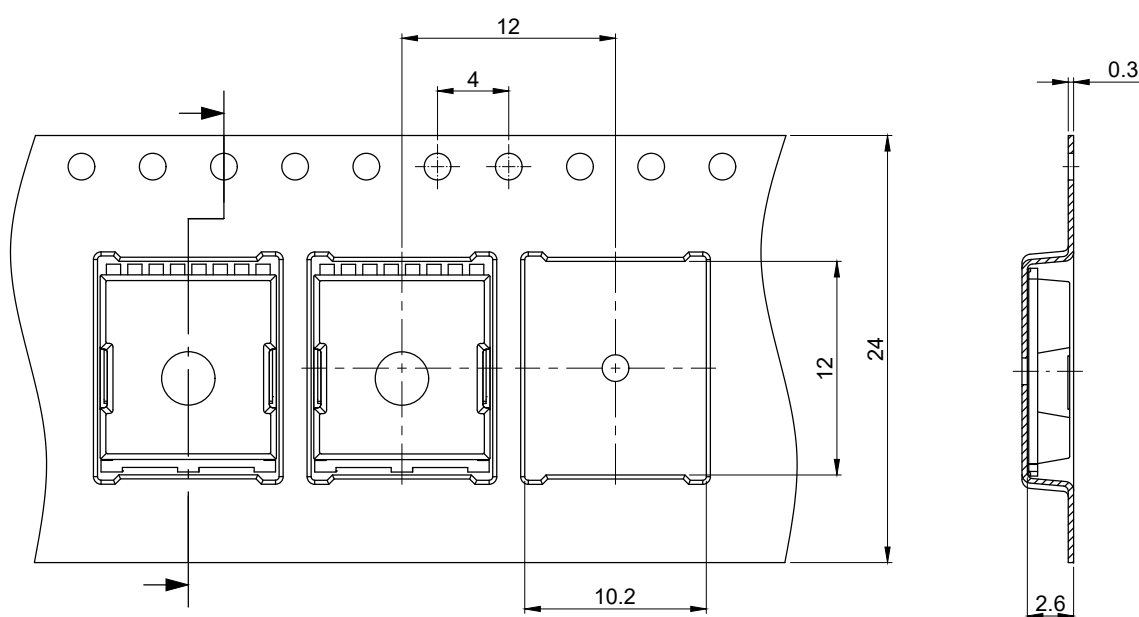


PACKAGE - GROUP NUMBER: <b>PG-HSOF-8-U02</b>		
DIMENSIONS	MILLIMETERS	
	MIN.	MAX.
<b>A</b>	2.20	2.40
<b>b</b>	0.70	0.90
<b>b1</b>	9.70	9.90
<b>b2</b>	0.42	0.50
<b>c</b>	0.40	0.60
<b>D</b>	10.28	10.58
<b>D1</b>	3.30	
<b>E</b>	9.70	10.10
<b>E1</b>	7.50	
<b>E2</b>	8.50	
<b>E3</b>	9.46	
<b>e</b>	1.20 (BSC)	
<b>H</b>	11.48	11.88
<b>H1</b>	6.55	6.95
<b>H2</b>	7.15	
<b>H3</b>	3.59	
<b>H4</b>	3.26	
<b>N</b>	8	
<b>K1</b>	4.18	
<b>L</b>	1.40	1.80
<b>L1</b>	0.50	0.90
<b>L2</b>	0.50	0.70
<b>L3</b>	1.00	1.30
<b>L4</b>	2.62	2.81


1) PARTIALLY COVERED WITH MOLD FLASH

**Figure 1** Outline PG-HSOF-8, dimensions in mm


**Figure 2 Footprint drawing PG-HSOF-8, dimensions in mm**



All dimensions are in units mm

The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]

**Figure 3** Packaging variant PG-HSOF-8, dimensions in mm

## 7 Appendix A

**Table 11**    **Related links**

- [IFX CoolMOS CM8 Webpage](#)
- [IFX CoolMOS CM8 application note](#)
- [IFX CoolMOS CM8 simulation model](#)
- [IFX Design tools](#)

## Revision history

IPT60R099CM8

### Revision 2024-10-30, Rev. 2.0

Previous revisions

Revision	Date	Subjects (major changes since last revision)
2.0	2024-10-30	Change of SOA diagram scaling

### Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

**We Listen to Your Comments** Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: [erratum@infineon.com](mailto:erratum@infineon.com)

### Published by

Infineon Technologies AG  
81726 München, Germany  
© 2024 Infineon Technologies AG  
All Rights Reserved.

### Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.